AP503

DCS-band 4W HBT Amplifier Module

The Communications Edge ™

Product Information

Product Features

- 1805 – 1880 MHz
- 32.2 dB Gain
- +25 dBm CDMA2k 7*fa* Power
  (-64 dBc ACPR)
- +12 V Single Supply
- Power Down Mode
- Bias Current Adjustable
- RoHS-compliant flange-mount pkg

Applications

- Final stage amplifiers for Repeaters
- Optimized for driver amplifier PA mobile infrastructure

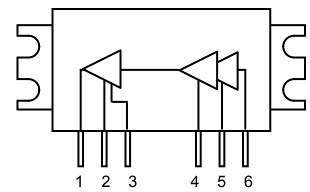
Product Description

The AP503 is a high dynamic range power amplifier in a RoHS-compliant flange-mount package. The multi-stage amplifier module has 31.5 dB gain. The module has been internally optimized for linearity to provide +25 dBm (-64 dBc ACPR) linear power for 7-carrier CDMA2000 applications.

The AP503 uses a high reliability InGaP/GaAs HBT process technology and does not require any external matching components. The module operates off of a +12V supply and does not requiring any negative biasing voltages; an internal active bias allows the amplifier to maintain high linearity over temperature. It has the added feature of a +5V power down control pin. While the module has been tuned for optimal performance for Class AB applications, the quiescent current can also be adjusted for Class B applications through an external resistor. A low-cost metal housing allows the device to have a low thermal resistance and achieves over 100 years MTTF. All devices are 100% RF and DC tested.

The AP503 is targeted for use as a driver or final stage amplifier in wireless infrastructure where high linearity and high power is required. This combination makes the device an excellent candidate for next generation multi-carrier 3G base stations using the DCS1800 frequency band.

Functional Diagram



Top View

Pin No.	Function
1	RF Output
2 / 4	Vcc
3 / 5	Vpd
6	RF Input
Case	Ground

Specifications (1)

25 ºC, V_{cc}=12V, V_{pd}=5V, I_{cq}=835mA, R7=0Ω, 50Ω unmatched fixture

Parameter	Units	Min	Typ	Max	Test Conditions
Operational Bandwidth	MHz		1805 – 1880		
Test Frequency	MHz		1845		
Adjacent Channel Power Ratio	dBc		-63.8	-61	CDMA2000 7*fa* 25 dBm Total Power, 885 kHz offset
Power Gain	dB	29.5	32.2	34.5	Pout = +25 dBm
Input Return Loss	dB		11		
Output Return Loss	dB		6		
Output P1dB	dBm		+36		
Output IP3	dBm		+50		Pout = +23 dBm/tone, Δf = 1 MHz
Operating Current (2)	mA	790	850	940	Pout = +25 dBm
Quiescent Current, Icq (2)	mA	780	835	920	
Device Voltage, Vcc	V		+12		
Device Voltage, Vpd	V		+5		Pull-down voltage: 0V = "OFF", 5V="ON"
Load Stability	VSWR	10:1			

1. Test conditions unless otherwise noted: 25ºC.
2. The current can be adjusted through an external resistor from the 5V supply to the pull-down voltage pin (pin 3).

Absolute Maximum Rating

Parameter	Rating
Operating Case Temperature	-40 to +85 °C
Storage Temperature	-55 to +150 °C
RF Input Power (continuous) with output terminated in 50 Ω	+15 dBm

Operation of this device above any of these parameters may cause permanent damage.

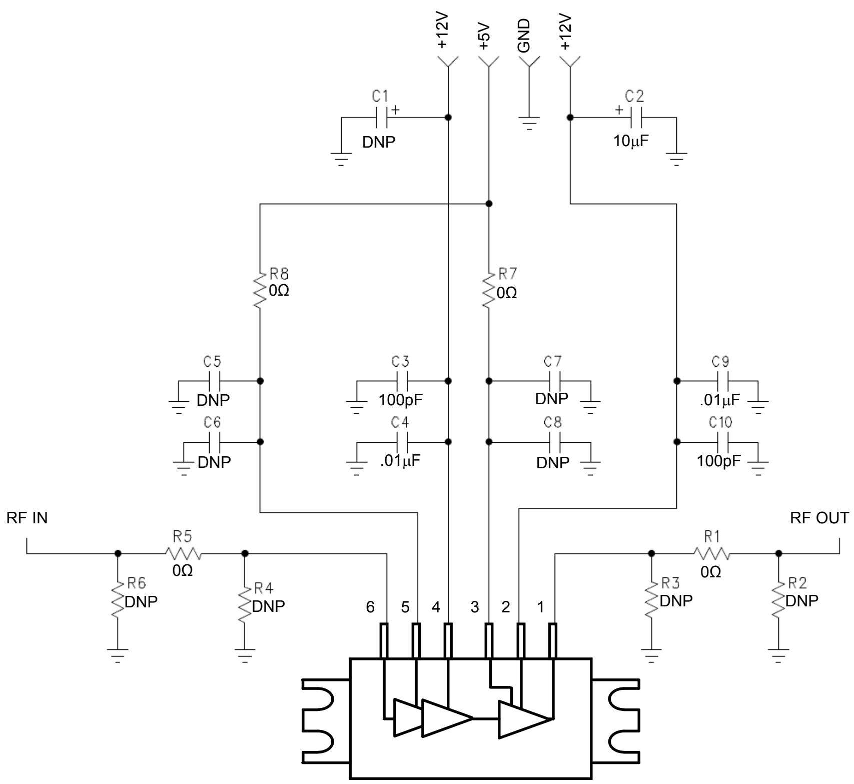
Ordering Information

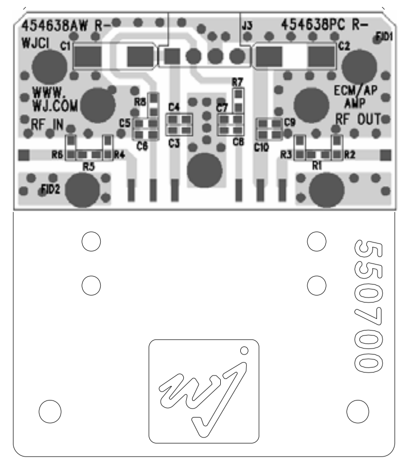
Part No.	Description
AP503	DCS-band 4W HBT Amplifier Module
AP503-PCB	Fully-Assembled Evaluation Board (Class AB configuration, Icq=835mA)

Specifications and information are subject to change without notice

Performance Graphs – Class AB Configuration (AP503-PCB)

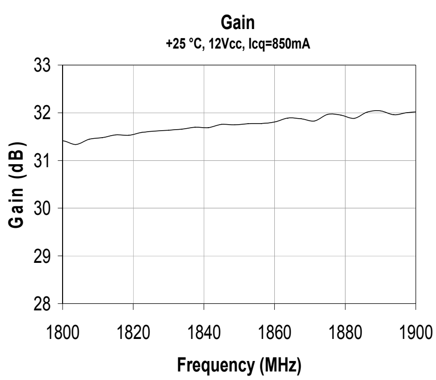
The AP503-PCB and AP503 module is configured for Class AB by default. The resistor – R7 – which sets the current draw for the amplifier is set at 0 Ω in this configuration. Increasing that value will decrease the quiescent and operating current of the amplifier module, as described on the next page.

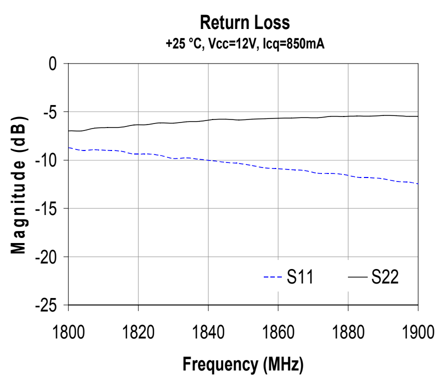


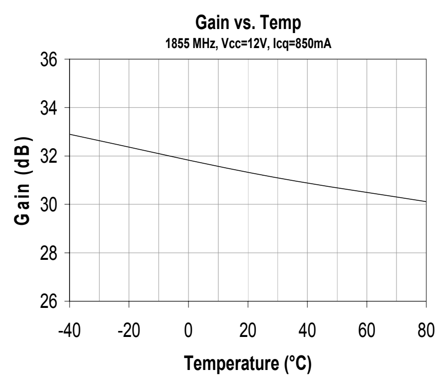


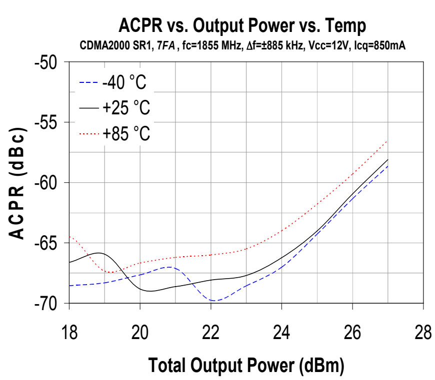
Notes:

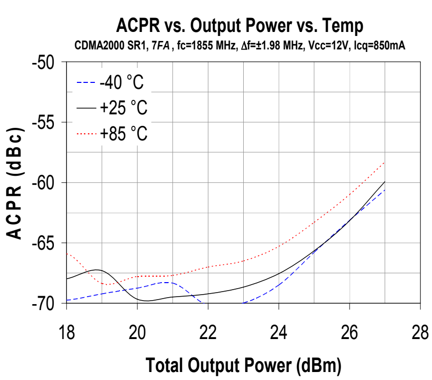
1. Please note that for reliable operation, the evaluation board will have to be mounted to a much larger heat sink during operation and in laboratory environments to dissipate the power consumed by the device. The use of a convection fan is also recommended in laboratory environments. Details of the mounting holes used in the WJ heatsink are given on the last page of this datasheet.
2. The area around the module underneath the PCB should not contain any soldermask in order to maintain good RF grounding.
3. For proper and safe operation in the laboratory, the power-on sequencing should be followed:
   1. Connect RF In and Out
   2. Connect the voltages and ground pins as shown in the circuit.
   3. Apply the RF signal
   4. Power down with the reverse sequence

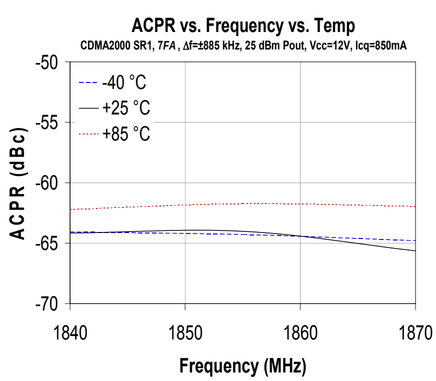




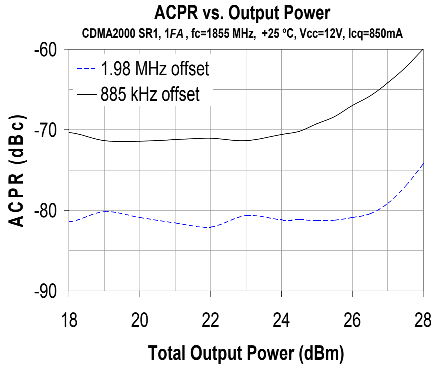


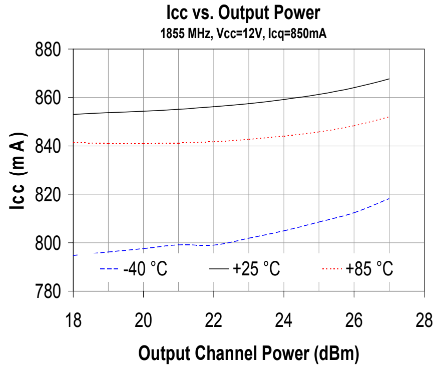


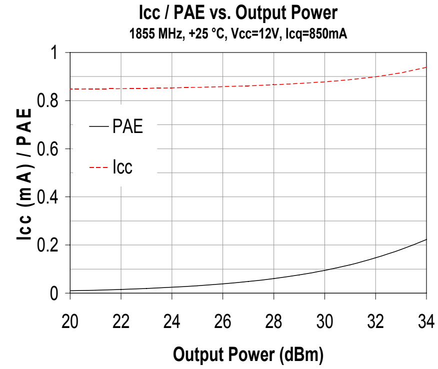


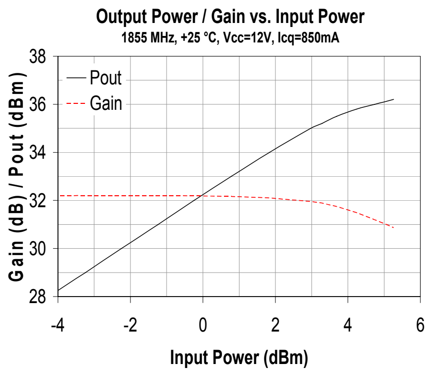


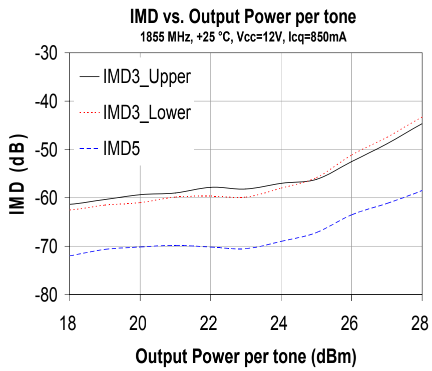
Performance Graphs (cont'd)

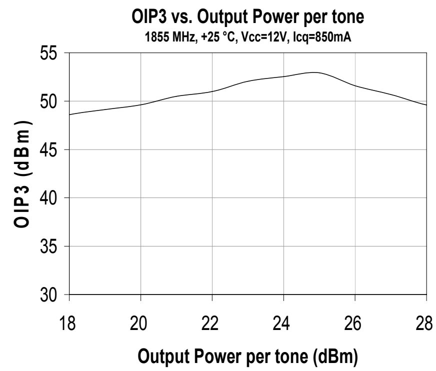












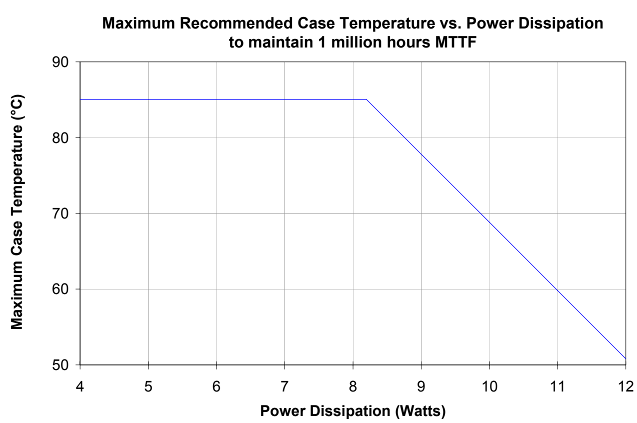
MTTF Calculation

The MTTF of the AP503 can be calculated by first determining how much power is being dissipated by the amplifier module. Because the device's intended application is to be a power amplifier pre-driver or final stage output amplifier, the output RF power of the amplifier will help lower the overall power dissipation. In addition, the amplifier can be biased with different quiescent currents, so the calculation of the MTTF is custom to each application.

The power dissipation of the device can be calculated with the following equation:

$P_{diss} = V_{cc} * I_{cc}$ – (Output RF Power – Input RF Power),
V_{cc} = Operating supply voltage = **12V**
I_{cc} = Operating current
{The RF power is converted to Watts}

While the maximum recommended case temperature on the datasheet is listed at 85 ˚C, it is suggested that customers maintain an MTTF above 1 million hours. This would convert to a derating curve for maximum case temperature vs. power dissipation as shown in the plot below.



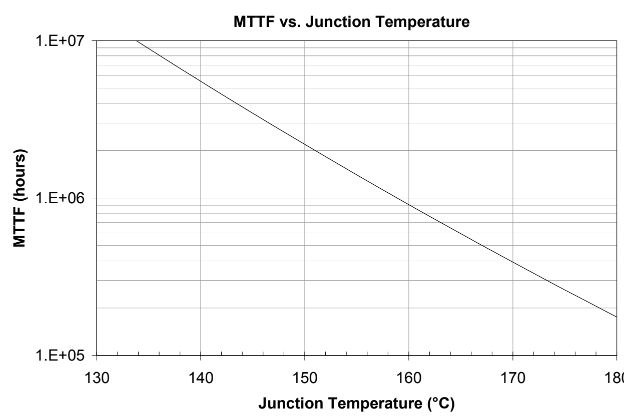
To calculate the MTTF for the module, the junction temperature needs to be determined. This can be easily calculated with the module's power dissipation, the thermal resistance value, and the case temperature of operation:

$T_j = P_{diss} * R_{th} + T_{case}$
T_j = Junction temperature
P_{diss} = Power dissipation (calculated from above)
R_{th} = Thermal resistance = **9 ˚C/W**
T_{case} = Case temperature of module's heat sink

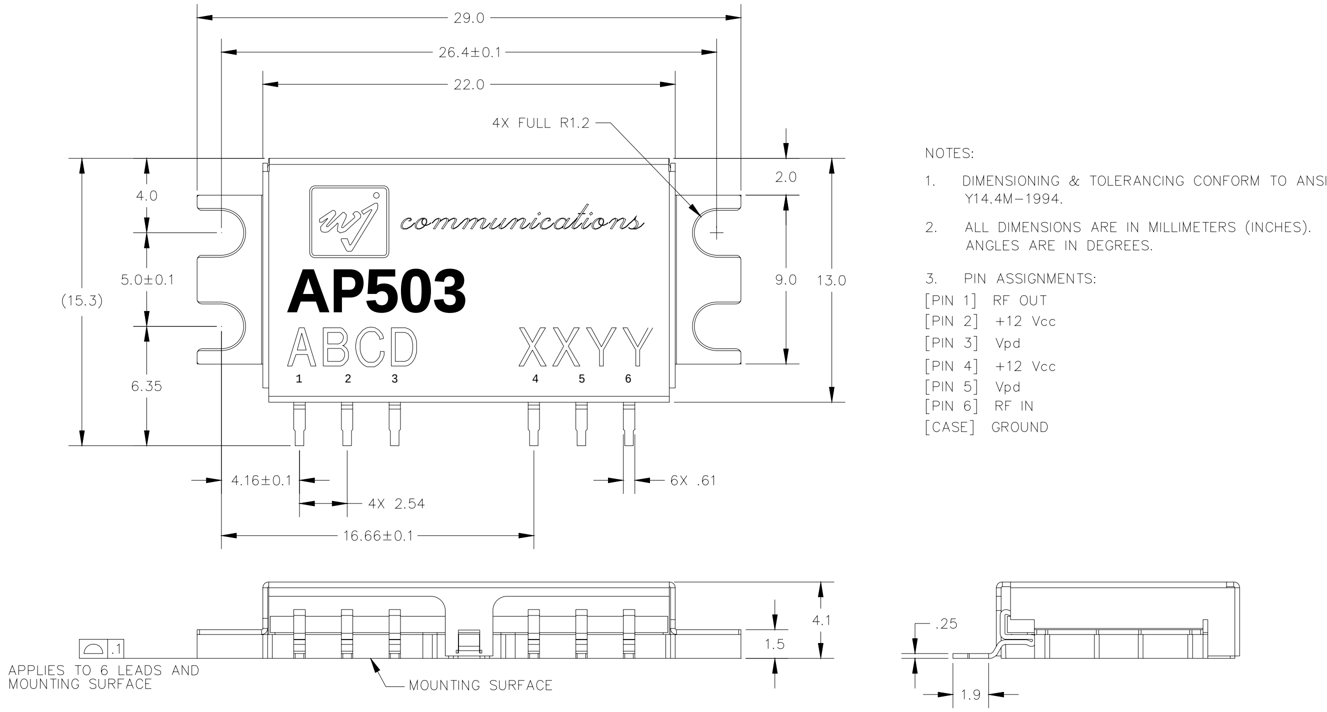
From a numerical standpoint, the MTTF can be calculated using the Arrhenius equation:

$MTTF = A * e^{(Ea/k/Tj)}$
A = Pre-exponential Factor = **6.087×10^{-11} hours**
Ea = Activation Energy = **1.39 eV**
k = Boltzmann's Constant = **8.617×10^{-5} eV/ ºK**
T_j = Junction Temperature (ºK) = T_j (ºC) + 273

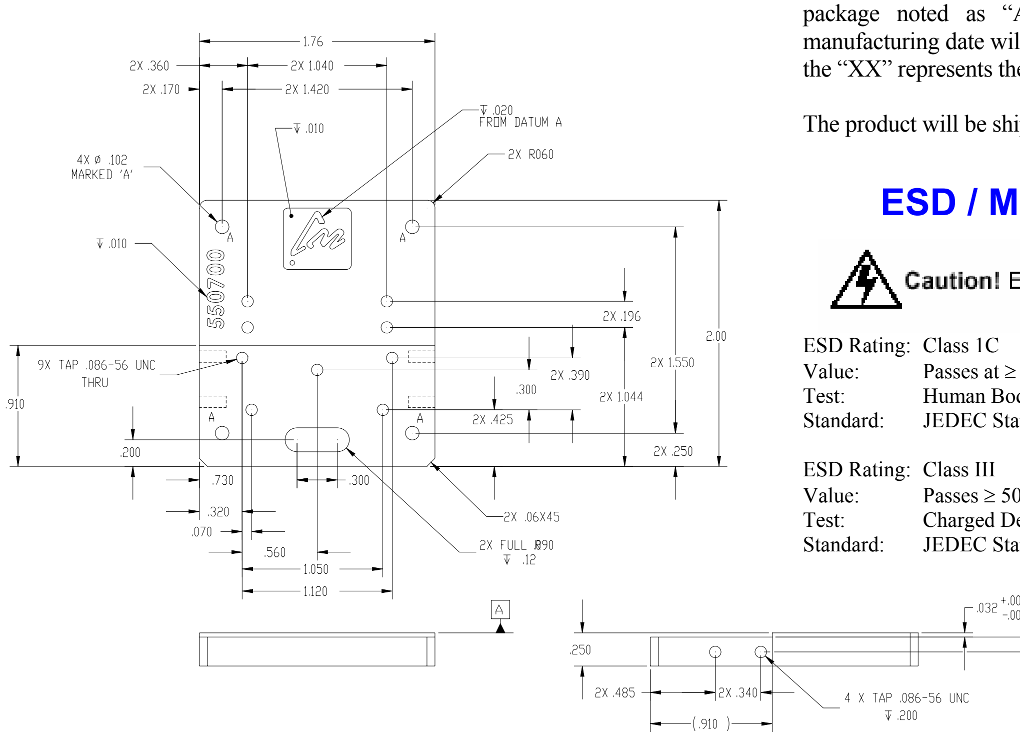
A graphical view of the MTTF can be shown in the plot below.



Outline Drawing



Outline Drawing for the Heatsink with the WJ Evaluation Board



Product Marking

The device will be marked with an "AP503" designator with an alphanumeric lot code on the top surface of the package noted as "ABCD" on the drawing. A manufacturing date will also be printed as "XXYY", where the "XX" represents the week number from 1 – 52.

The product will be shipped in tubes in multiples of 15.

ESD / MSL Information

ESD Rating:	Class 1C
Value:	Passes at ≥ 1,000 to < 2,000 volts
Test:	Human Body Model (HBM)
Standard:	JEDEC Standard JESD22-A114

ESD Rating:	Class III
Value:	Passes ≥ 500 to < 1,000 volts
Test:	Charged Device Model (CDM)
Standard:	JEDEC Standard JESD22-C101